PCI-EXPRESS CLOCK SOURCE

Description

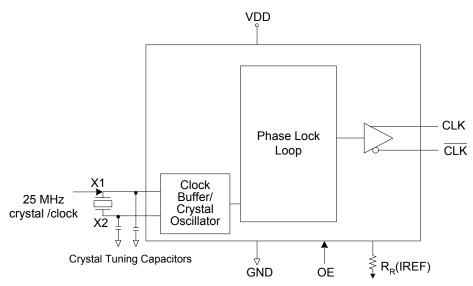
The ICS557-01 is a clock chip designed for use in PCI-Express Cards as a clock source. It provides a pair of differential outputs at 100 MHz in a small 8-pin SOIC package.

Using ICS' patented Phase-Locked Loop (PLL) techniques, the device takes a 25 MHz crystal input and produces HCSL (Host Clock Signal Level) differential outputs at 100 MHz clock frequency. LVDS signal levels can also be supported via an alternative termination scheme.

Features

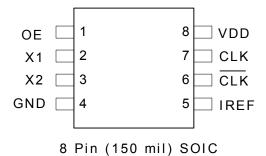
- Supports PCI-ExpressTM HCSL Outputs 0.7 V current mode differential pair
- Supports LVDS Output Levels
- Packaged in 8-pin SOIC
- Available in Pb (lead) free package
- Operating voltage of 3.3 V
- Low power consumption
- Input frequency of 25 MHz
- Short term jitter 100 ps (peak-to-peak)
- Output Enable via pin selection
- Industrial temperature range available

Block Diagram





Pin Assignment



Pin Descriptions

Pin Number	Pin Name	Pin Type	Pin Description
1	OE	Input	Output Enable signal (H = outputs are enabled, L = outputs are disabled/tristated). Internal pull-up resistor.
2	X1	Input	Crystal or clock input. Connect to a 25 MHz crystal or single ended clock.
3	X2	ХО	Crystal Connection. Connect to a parallel mode crystal. Leave floating if clock input.
4	GND	Power	Connect to ground.
5	IREF	Output	A 475 Ω precision resistor connected between this pin and ground establishes the external reference current.
6	CLK	Output	HCSL differential complementary clock output.
7	CLK	Output	HCSL differential clock output.
8	VDD	Power	Connect to +3.3 V.



Applications Information

External Components

A minimum number of external components are required for proper operation.

Decoupling Capacitors

Decoupling capacitors of 0.01 μ F should be connected between VDD and the ground plane (pin 4) as close to the VDD pin as possible. Do not share ground vias between components. Route power from power source through the capacitor pad and then into ICS pin.

Crystal

A 25 MHz fundamental mode parallel resonant crystal with C_L = 16 pF should be used. This crystal must have less than 300 ppm of error across temperature in order for the ICS557-01 to meet PCI Express specifications.

Crystal Capacitors

Crystal capacitors are connected from pins X1 to ground and X2 to ground to optimize the accuracy of the output frequency.

C_I = Crystal's load capacitance in pF

Crystal Capacitors (pF) = $(C_1 - 8) * 2$

For example, for a crystal with a 16 pF load cap, each external crystal cap would be 16 pF. (16-8)*2=16.

Current Source (Iref) Reference Resistor - RR

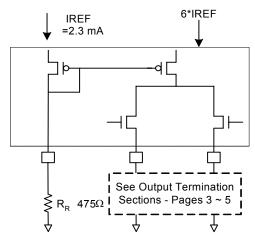
If board target trace impedance (Z) is 50Ω , then R_R = 475Ω (1%), providing IREF of 2.32 mA. The output current (I_{OH}) is equal to 6*IREF.

Output Termination

The PCI-Express differential clock outputs of the ICS557-01 are open source drivers and require an external series resistor and a resistor to ground. These resistor values and their allowable locations are shown in detail in the **PCI-Express Layout Guidelines** section.

The ICS557-01can also be configured for LVDS compatible voltage levels. See the LVDS Compatible Layout Guidelines section

Output Structures



General PCB Layout Recommendations

For optimum device performance and lowest output phase noise, the following guidelines should be observed.

- 1. Each $0.01\mu F$ decoupling capacitor should be mounted on the component side of the board as close to the VDD pin as possible.
- 2. No vias should be used between decoupling capacitor and VDD pin.
- 3. The PCB trace to VDD pin should be kept as short as possible, as should the PCB trace to the ground via. Distance of the ferrite bead and bulk decoupling from the device is less critical.
- 4. An optimum layout is one with all components on the same side of the board, minimizing vias through other signal layers (any ferrite beads and bulk decoupling capacitors can be mounted on the back). Other signal traces should be routed away from the ICS557-01. This includes signal traces just underneath the device, or on layers adjacent to the ground plane layer used by the device.



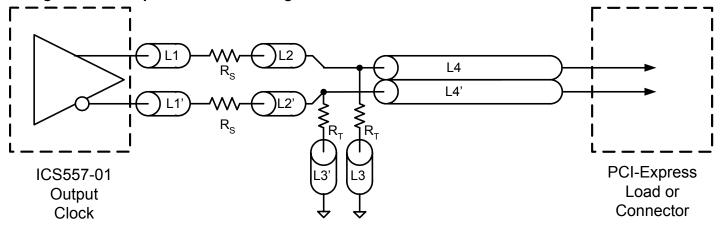
PCI-Express Layout Guidelines

lecommendations for Differential Routing	Dimensio
as non-coupled 50 ohm trace.	0.5
as non-coupled 50 ohm trace.	0.2
as non-coupled 50 ohm trace.	0.2
	3
	49

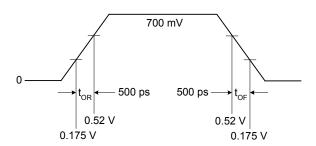
ferential Routing on a Single PCB	Dimensio
as coupled microstrip 100 ohm differential trace.	2 min to
as coupled stripline 100 ohm differential trace.	1.8 min to

ial Routing to a PCI Express Connector	Dimensio
as coupled microstrip 100 ohm differential trace.	0.25 to
as coupled stripline 100 ohm differential trace.	0.225 min

Figure 1: PCI-Express Device Routing



Typical PCI-Express (HCSL) Waveform



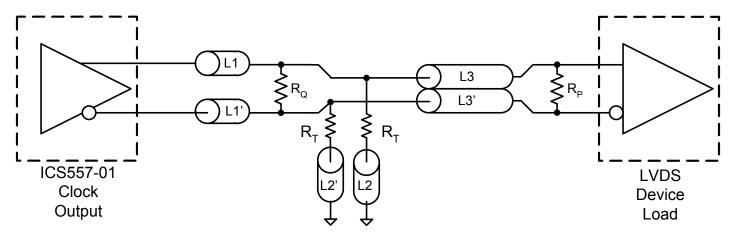
MDS 557-01 F 4 Revision 011606



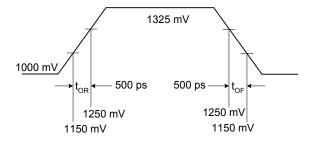
LVDS Compatible Layout Guidelines

LVDS Recommendations for Differential Routing	Dimension or Value	Unit
L1 length, Route as non-coupled 50 ohm trace.	0.5 max	inch
L2 length, Route as non-coupled 50 ohm trace.	0.2 max	inch
R_{P}	100	ohm
R_{Q}	100	ohm
R_{T}	150	ohm
L3 length, Route as coupled 50 ohm differential trace.		
L3 length, Route as coupled 50 ohm differential trace.		

Figure 3: LVDS Device Routing



Typical LVDS Waveform





Absolute Maximum Ratings

Stresses above the ratings listed below can cause permanent damage to the ICS557-01. These ratings are stress ratings only. Functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods can affect product reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

Item	Rating
Supply Voltage, VDD, VDDA	5.5 V
All Inputs and Outputs	-0.5 V to VDD+0.5 V
Ambient Operating Temperature (commercial)	0 to +70°C
Ambient Operating Temperature (industrial)	-40 to +85°C
Storage Temperature	-65 to +150°C
Junction Temperature	125°C
Soldering Temperature	260°C
ESD Protection (Input)	2000 V min. (HBM)

DC Electrical Characteristics

Unless stated otherwise, VDD = 3.3 V ±5%, Ambient Temperature -40 to +85°C

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Supply Voltage	V		3.135		3.465	
Input High Voltage ¹	V _{IH}		2.0		VDD +0.3	V
Input Low Voltage ¹	V _{IL}		VSS-0.3		0.8	V
Input Leakage Current ²	I _{IL}	0 < Vin < VDD	-5		5	μΑ
Operating Supply Current	I _{DD}	With 50Ω and 2 pF load			55	mA
	I _{DDOE}	OE =Low			35	mA
Input Capacitance	C _{IN}	Input pin capacitance			7	pF
Output Capacitance	C _{OUT}	Output pin capacitance			6	pF
Pin Inductance	L _{PIN}				5	nH
Output Resistance	Rout	CLK outputs	3.0			kΩ
Pull-up Resistor	R _{PUP}	OE		60		kΩ

 $^{^{1}}$ Single edge is monotonic when transitioning through region. 2 Inputs with pull-ups/-downs are not included.



AC Electrical Characteristics - CLK/CLK

Unless stated otherwise, VDD=3.3 V ±5%, Ambient Temperature -40 to +85°C

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Input Frequency				25		MHz
Output Frequency				100		MHz
Output High Voltage ^{1,2}	V _{OH}		660	700	850	mV
Output Low Voltage ^{1,2}	V _{OL}		-150	0		mV
Crossing Point Voltage ^{1,2}		Absolute	250	350	550	mV
Crossing Point Voltage ^{1,2,4}		Variation over all edges			140	mV
Jitter, Cycle-to-Cycle ^{1,3}				100		ps
Rise Time ^{1,2}	t _{OR}	from 0.175 V to 0.525 V	175	332	700	ps
Fall Time ^{1,2}	t _{OF}	from 0.525 V to 0.175 V	175	344	700	ps
Rise/Fall Time Variation ^{1,2}					125	ps
Duty Cycle ^{1,3}			45		55	%
Output Enable Time ⁵		All outputs		30		μs
Output Disable Time ⁵		All outputs		30		μs
Stabilization Time	t _{STABLE}	From power-up VDD=3.3 V		3.0		ms
Spread Change Time	t _{SPREAD}	Settling period after spread change		3.0		ms

¹ Test setup is R_L =50 ohms with 2 pF, R_R = 475 Ω (1%).

Thermal Characteristics (8-pin SOIC)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Thermal Resistance Junction to	$\theta_{\sf JA}$	Still air		150		°C/W
Ambient	$\theta_{\sf JA}$	1 m/s air flow		140		°C/W
	$\theta_{\sf JA}$	3 m/s air flow		120		°C/W
Thermal Resistance Junction to Case	$\theta_{\sf JC}$			40		°C/W

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² Measurement taken from a single-ended waveform.

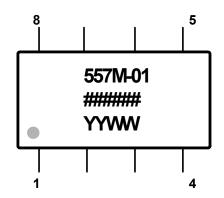
³ Measurement taken from a differential waveform.

⁴ Measured at the crossing point where instantaneous voltages of both CLKOUT and CLKOUT are equal.

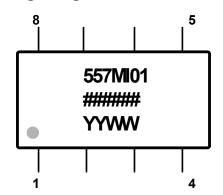
⁵ CLKOUT pins are tri-stated when OE is low asserted. CLKOUT is driven differential when OE is high.



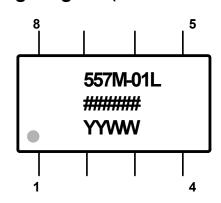
Marking Diagram (ICS557M-01)



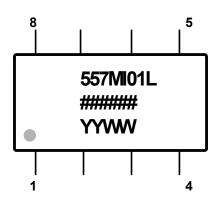
Marking Diagram (ICS557MI-01)



Marking Diagram (ICS557M-01LF)



Marking Diagram (ICS557MI-01LF)



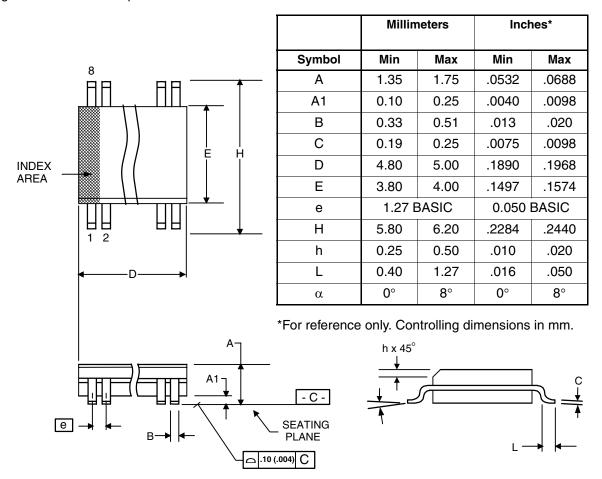
Notes:

- 1. ##### is the lot code.
- 2. YYWW is the last two digits of the year, and the week number that the part was assembled.
- 3. "L" designates Pb (lead) free packaging.
- 4. Bottom marking: (orgin). Origin = country of origin if not USA.



Package Outline and Package Dimensions (8-pin SOIC, 150 Mil. Narrow Body)

Package dimensions are kept current with JEDEC Publication No. 95





Ordering Information

Part / Order Number	Marking	Shipping Packaging	Package	Temperature
ICS557M-01	See Page 8	Tubes	8-pin SOIC	0 to +70° C
ICS557M-01T		Tape and Reel	8-pin SOIC	0 to +70° C
ICS557M-01LF		Tubes	8-pin SOIC	0 to +70° C
ICS557M-01LFT		Tape and Reel	8-pin SOIC	0 to +70° C
ICS557MI-01		Tubes	8-pin SOIC	-40 to +85° C
ICS557MI-01T		Tape and Reel	8-pin SOIC	-40 to +85° C
ICS557MI-01LF		Tubes	8-pin SOIC	-40 to +85° C
ICS557MI-01LFT		Tape and Reel	8-pin SOIC	-40 to +85° C

Parts that are ordered with a "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

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